

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/660,053	TAKIZAWA ET AL.
Examiner	Art Unit	
Khiem D. Nguyen	2823	

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	59	12/9/2005	K.N.
257	72	12/9/2005	K.N.
438	149	12/9/2005	K.N.